## pco.edge 4.2 bi XU

optimized for EUV & soft X-ray applications



interface	USB 3.1 Gen 1
sensor technology	sCMOS PulSar
spectral range [nm]	1 to 1100 (1.2 keV to 1.1 eV)
resolution [pixel]	2048 x 2048
sensor diagonal [mm]	18.8
pixel size [µm]	6.5 x 6.5
max. frame rate @ full resolution [fps]	40 (16 bit)
max. pixel rate [MPixel/s]	184 (16 bit)
peak QE	> 95 % @ 2.28 nm
typ. read noise¹ [e⁻]	1.9
dark current @ sensor temperature [e <sup>-</sup> /pixel/s]	0.2 @ -25 °C
max. dynamic range	26,667:1
shutter type	RS (Rolling Shutter), GR (Global Reset)
sensor cooling <sup>2</sup>	adjustable: from -25 °C to +20 °C peltier with forced air (fan) and water cooling, calibration setpoint: -10 °C
dimensions <sup>3</sup> H x W x L [mm]	152 x 152 x 99
opto-mechanical interface	CF100-flange

## <sup>1</sup> The readout noise values are given as median (med). All values are raw data without any filtering.



down to 1 x 10<sup>-7</sup> mbar

The pco.edge 4.2 bi XU is based on a back illuminated sCMOS sensor with a very specific coating which allows applications in the visible light down to extreme UV (EUV) and soft X-ray radiation. The camera is adapted for ultra-high vacuum operations and has been characterized using soft X-ray in the energy range from 30 eV to 1000 eV. The image sensor features 2048 x 2048 pixel with a pixel size of 6.5  $\mu m$  x 6.5  $\mu m$  and allows full frame acquisitions at 40 Hz with a dynamic range of 88 dB at a noise level of 1.9 e med. The camera is compact and offers various software integration options.





<sup>&</sup>lt;sup>2</sup> air = air forced with fan | water = external water connection

<sup>&</sup>lt;sup>3</sup> incl. CF100-flange